									
AD4616 Complementary Enhancement Mode Field Effect Transistor									
General Descrip The AO4616 uses a technology MOSFE R _{DS(ON)} and low gate complementary MO3 inverter and other a <i>Product AO4616 is a</i> & Sony 259 specific Green Product orde and AO4616L are e	dvanced trer Ts to provide charge. The SFETs may oplications.S Pb-free (mee ations). AO4 ring option.	e excellent e be used in tandard ets ROHS 616L is a AO4616	R _{DS(ON)} < 20mΩ	el	R _{DS(ON)} < 25n	nnel . (V _{GS} = -10\ nΩ (V _{GS} = nΩ (V _{GS} =	10V)		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$			D2 D2 D1 D1 D1 G1 G1 S1 n-channel p-channel						
Absolute Maximum	Ratings T _A =			1					
Parameter			Symbol	1	channel	Max p-channel		Units V	
Drain-Source Voltage		V _{DS}	-	30		-30			
		V _{GS}	±20		±20		V		
Continuous Drain	T _A =25°C				.1	-7.1			
Current ^A	T _A =70°C		I _D		.5	-5.6		A	
Pulsed Drain Current	ulsed Drain Current ^B		I _{DM}	30		-30			
	T _A =25°C		PD	2		2		w	
Power Dissipation T _A =70°C		• D	1.28		1.28				
Junction and Storage Temperature Range			T _J , T _{STG}	-55 to 150		-55 to 150		°C	
Thermal Characteris	stics: n-cha	nnel and p-	channel	Cumple - I	Devile	T	M	11	
Parameter Maximum Junction-to	Ambiont ^A	t≤	10s	Symbol	Device	Typ	Max 62.5	Units °C/W	
		t ≤ Steady		R _{0JA}	n-ch n-ch	48	110	°C/W	
Maximum Junction-to-Ambient ^A Steady Maximum Junction-to-Lead ^C Steady			R	n-ch	35	60	°C/W		
		t ≤		R _{θJL}	p-ch	48	62.5	°C/W	
Maximum Junction-to-Ambient ^A t ≤ Maximum Junction-to-Ambient ^A Steady			$R_{\theta JA}$	p-ch	40 74	110	°C/W		
Maximum Junction-to-Lead ^C Steady			$R_{ ext{ heta}JL}$	p-ch	35	40	°C/W		

Symbol	Parameter	Conditions	Min	Тур	Max	Units
STATIC F	PARAMETERS					
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μΑ, V _{GS} =0V	30			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =24V, V _{GS} =0V			1	μA
		T _J =55°C	;		5	
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±20V			100	nA
V _{GS(th)}	Gate Threshold Voltage	$V_{DS}=V_{GS}$ $I_{D}=250\mu A$	1	1.8	3	V
ID _(ON)	On state drain current	V _{GS} =10V, V _{DS} =5V	30			Α
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =8.1A		16.4	20	mΩ
		T _J =125°C	;	20	25	
		V _{GS} =4.5V, I _D =6A		23.4	28	mΩ
g fs	Forward Transconductance	V _{DS} =5V, I _D =8.1A		23		S
V_{SD}	Body-Diode Forward Voltage	I _S =1A		0.75	1	V
ls	Maximum Body-Diode Continuous Current				3	Α
DYNAMI	C PARAMETERS			-		-
C _{iss}	Input Capacitance			1040	1250	pF
C _{oss}	Output Capacitance	V _{GS} =0V, V _{DS} =15V, f=1MHz		180		pF
C _{rss}	Reverse Transfer Capacitance			110		pF
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		0.7		Ω
SWITCHI	NG PARAMETERS			-		-
Q _g (10V)	Total Gate Charge			19.2		nC
Q _g (4.5V)	Total Gate Charge			9.36		nC
Q _{gs}	Gate Source Charge	–––– V _{GS} =10V, V _{DS} =15V, I _D =8.1A		2.6		nC
Q_{gd}	Gate Drain Charge			4.2		nC
t _{D(on)}	Turn-On DelayTime			5.2		ns
t _r	Turn-On Rise Time	V _{GS} =10V, V _{DS} =15V, R _L =1.8Ω,		4.4		ns
t _{D(off)}	Turn-Off DelayTime	R _{GEN} =3Ω		17.3		ns
t _f	Turn-Off Fall Time			3.3		ns
t _{rr}	Body-Diode Reverse Recovery Time	I _F =8.1A, dl/dt=100A/μs	1	16.7	21	ns
Q _{rr}	Body-Diode Reverse Recovery Charge	I _F =8.1A, dl/dt=100A/μs		6.7	10	nC

N-Channel Electrical Characteristics (T_J=25°C unless otherwise noted)

A: The value of R $_{0JA}$ is measured with the device mounted on 1in ² FR-4 board with 2oz. Copper, in a still air environment with T $_{A}$ =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t \leq 10s thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

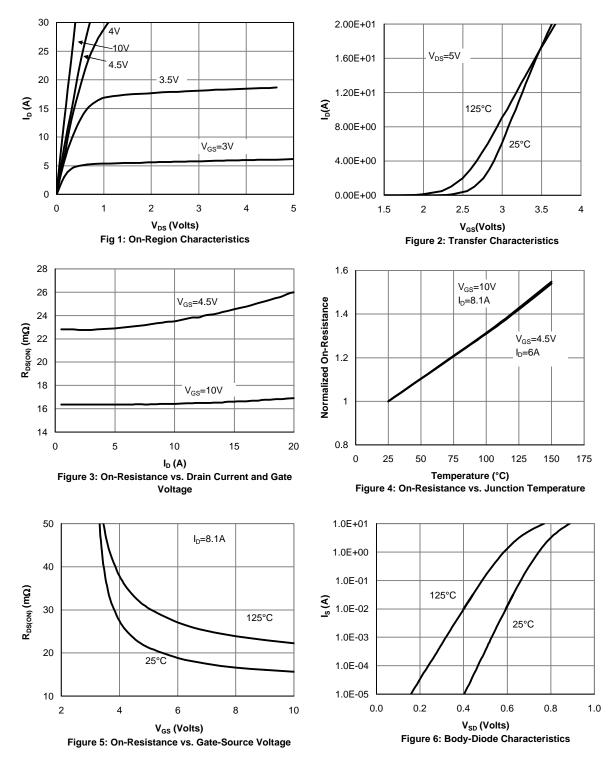
C. The R $_{\rm 0JA}$ is the sum of the thermal impedence from junction to lead R $_{\rm 0JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using 80 $\,\mu s$ pulses, duty cycle 0.5% max.

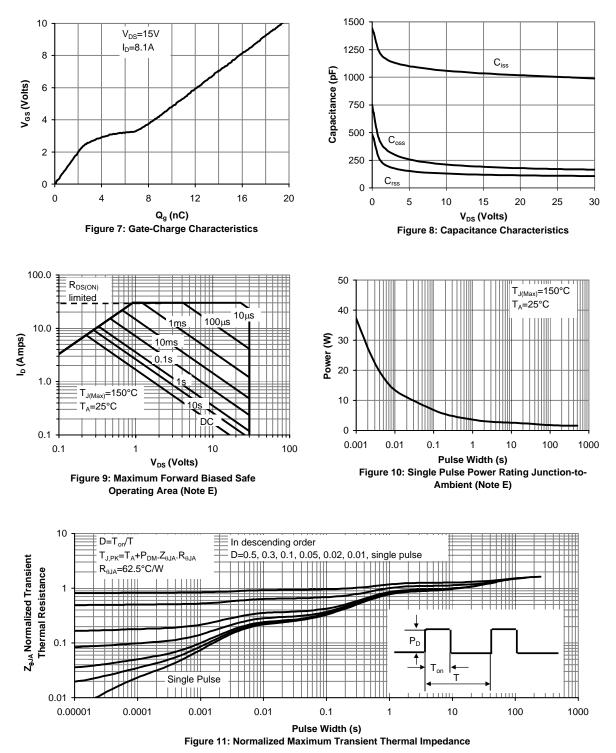
E. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T _A=25°C. The SOA curve provides a single pulse rating.

Rev 0 : July 2005

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N-CH TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



N-CH TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =-250μA, V _{GS} =0V		-30			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-24V, V _{GS} =0V				-1	μA
			T _J =55°C			-5	μΛ
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±20V				±100	nA
V _{GS(th)}	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=-250 \mu A$		-1.4	-2	-2.7	V
I _{D(ON)}	On state drain current	V _{GS} =-10V, V _{DS} =-5V		30			А
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =-10V, I _D =-7.1A			20	25	mΩ
			T _J =125°C		27	33	1115.2
		V _{GS} =-4.5V, I _D =-5.6A			29	40	mΩ
g fs	Forward Transconductance	V _{DS} =-5V, I _D =-7.1A			19.6		S
V _{SD}	Diode Forward Voltage	I _S =-1A,V _{GS} =0V			-0.7	-1	V
I _S	Maximum Body-Diode Continuous Current					-4.2	Α
DYNAMIC	C PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =-15V, f=1MHz			1573		pF
C _{oss}	Output Capacitance				319		pF
C _{rss}	Reverse Transfer Capacitance				211		pF
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz			6.7		Ω
SWITCHI	NG PARAMETERS						
Q _g (10V)	Total Gate Charge (10V)	V _{GS} =-10V, V _{DS} =-15V, I _D =-7.1A			30.9		nC
Q _g (4.5V)	Total Gate Charge (4.5V)				16.1		nC
Q _{gs}	Gate Source Charge				8		nC
Q _{gd}	Gate Drain Charge				4.4		nC
t _{D(on)}	Turn-On DelayTime	V _{GS} =-10V, V _{DS} =-15V, R _L =2.2Ω, R _{GEN} =3Ω			9.5		ns
t _r	Turn-On Rise Time				8		ns
t _{D(off)}	Turn-Off DelayTime				44.2		ns
t _f	Turn-Off Fall Time				22.2		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =-7.1A, dl/dt=100A/μs			25.5		ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =-7.1A, dI/dt=100A/μs			14.7		nC

P-Channel Electrical Characteristics (T_J=25°C unless otherwise noted)

A: The value of R _{0JA} is measured with the device mounted on 1in ² FR-4 board with 2oz. Copper, in a still air environment with T _A =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t \leq 10s thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

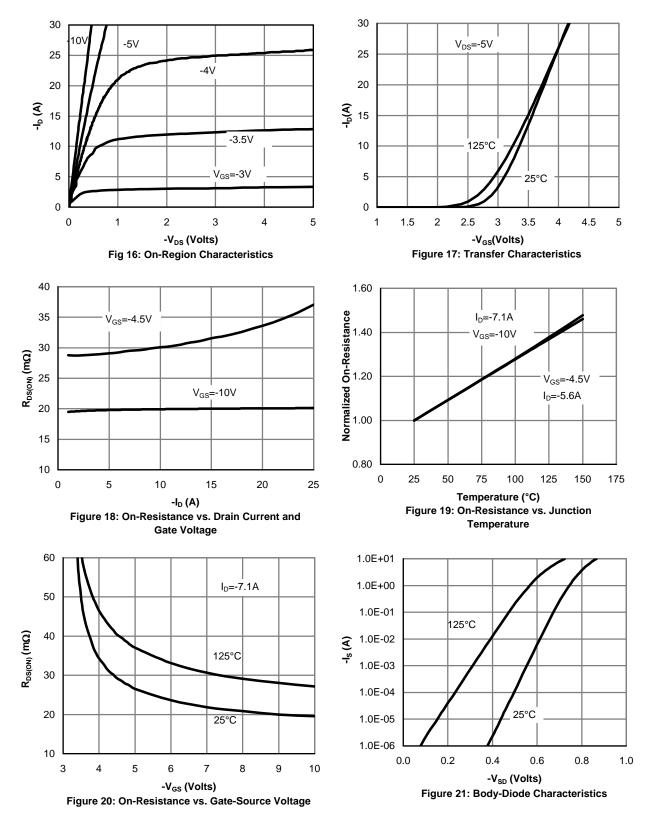
C. The R $_{\rm \theta JA}$ is the sum of the thermal impedence from junction to lead R $_{\rm \theta JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6,12,14 are obtained using 80 $\,\mu s$ pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The SOA curve provides a single pulse rating.

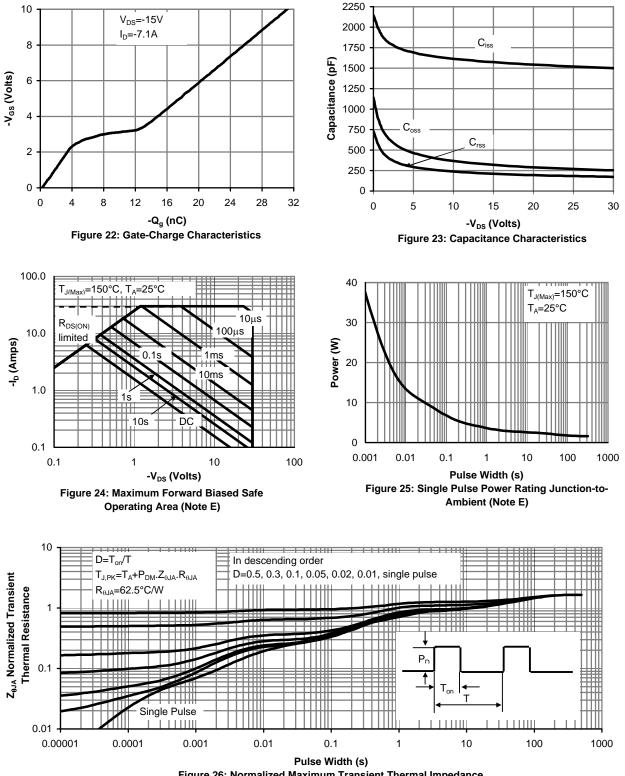
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Figure 26: Normalized Maximum Transient Thermal Impedance